# FAIRCHILD

April 2011

SEMICONDUCTOR®

# FDPF770N15A N-Channel PowerTrench<sup>®</sup> MOSFET 150V, 10A, 77mΩ

#### Features

- $R_{DS(on)} = 60m\Omega$  (Typ.)@  $V_{GS} = 10V$ ,  $I_D = 10A$
- Fast Switching Speed
- Low Gate Charge
- High Performance Trench Technology for Extremely Low  $R_{\text{DS}(\text{on})}$
- High Power and Current Handling Capability
- RoHS Compliant

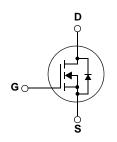
## Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advance PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

## Application

- DC to DC Converters
- Synchronous Rectification for Server/Telecom PSU
- Battery Charger
- AC Motor Drives and Uninterruptible Power Supplies
- Off-line UPS





#### MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

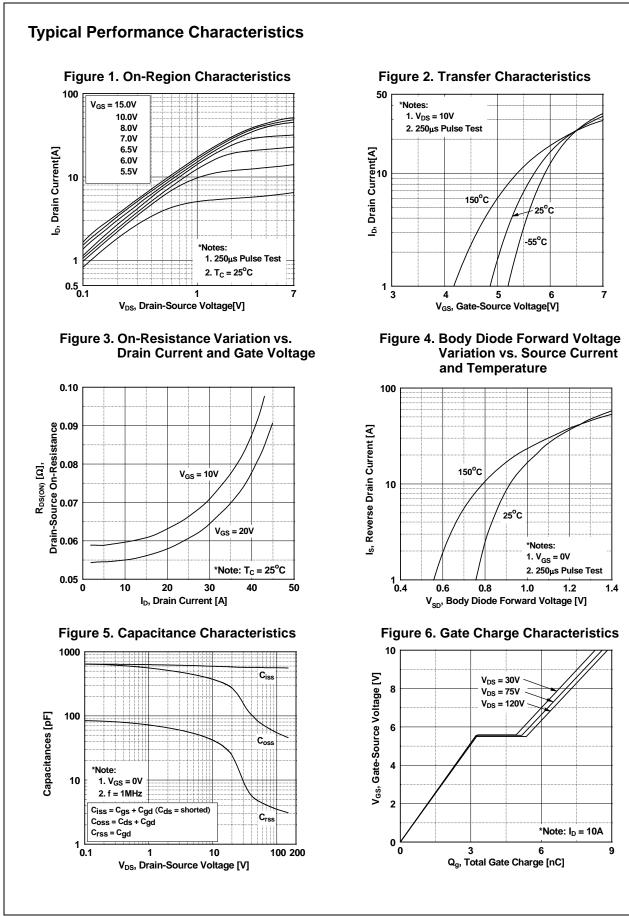
Symbol		Parameter		Ratings	Units
V <sub>DSS</sub>	Drain to Source Voltage			150	V
V <sub>GSS</sub>	Gate to Source Voltage			±20	V
I <sub>D</sub>	Drain Current	-Continuous (T <sub>C</sub> = 25°C,Silicon Li	-Continuous ( $T_C = 25^{\circ}C$ , Silicon Limited)-Continuous ( $T_C = 100^{\circ}C$ , Silicon Limited)		Α
	Drain Current	-Continuous (T <sub>C</sub> = 100 <sup>o</sup> C,Silicon			
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	40	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energy (		(Note 2)	35	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	6.0	V/ns
P <sub>D</sub>	Dower Dissinction	$(T_{C} = 25^{\circ}C)$		20	W
	Power Dissipation	- Derate above 25°C		0.16	W/ºC
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 to +150	°C
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

### **Thermal Characteristics**

Symbol	Parameter	Ratings	Units
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	5.9	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient	62.5	0/10

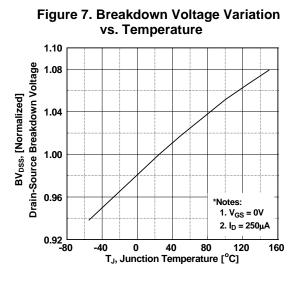
Device Ma	Device Marking Device P		Package	Reel Size	Тар	e Width		Quantit	у
FDPF770			TO-220F	-		-		50	
Electrica	l Char	racteristics ⊤ <sub>c</sub> =	25°C unless othe	rwise noted					
Symbol		Parameter		Test Conditions		Min.	Тур.	Max.	Units
Off Charac	toristic	·e	L		1	1		1	1
BV <sub>DSS</sub>		o Source Breakdown Vo		- 2504 Vac - 0V		150	-	-	V
ABV <sub>DSS</sub>		own Voltage Temperatu	Iro	I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0V		100			
$\Delta T_J$	Coefficient		I <sub>D</sub>	$I_D = 250\mu A$ , Referenced to $25^{\circ}C$		-	0.1	-	V/ºC
I	Zero Gate Voltage Drain Current		V <sub>D</sub>	$V_{DS} = 120V, V_{GS} = 0V$		-	-	1	
DSS	Zelo G	ale vollage Drain Curre	V <sub>D</sub>	$V_{DS} = 120V, T_{C} = 125^{\circ}C$			-	500	μA
I <sub>GSS</sub>	Gate to	Body Leakage Curren	t V <sub>G</sub>	$_{\rm S}$ = ±20V, V <sub>DS</sub> = 0V		-	-	±100	nA
On Charac	teristic	S							
V <sub>GS(th)</sub>		hreshold Voltage	Vc	<sub>S</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250μA		2.0	-	4.0	V
R <sub>DS(on)</sub>		tic Drain to Source On Resistance		$r_{S} = 10V, I_{D} = 10A$		-	60	77	mΩ
9FS		ard Transconductance		$V_{\rm DS} = 10V, I_{\rm D} = 10A$ (Note 4)		-	15	-	S
				0 0					
Dynamic C									
C <sub>iss</sub>		Capacitance		V <sub>DS</sub> = 75V, V <sub>GS</sub> = 0V		-	575	765	pF
C <sub>oss</sub>		Capacitance	f =	1MHz	-	-	64	85	pF
C <sub>rss</sub>		e Transfer Capacitance				-	3.9	-	pF
C <sub>oss(er)</sub>		Related Output Capac	itance V <sub>D</sub>	<sub>S</sub> = 75V,V <sub>GS</sub> = 0V			113	-	pF
Q <sub>g(tot)</sub>	Total G	ate Charge at 10V				-	8.6	11.2	nC
Q <sub>gs</sub>	Gate to	Source Gate Charge	VD	<sub>S</sub> = 75V,I <sub>D</sub> = 10A			3.2	-	nC
Q <sub>gs2</sub>	Gate C	harge Threshold to Pla	teau V <sub>G</sub>	<sub>S</sub> =10V		-	1.2	-	nC
Q <sub>gd</sub>	Gate to	Drain "Miller" Charge			(Note 4.5)	-	1.9	-	nC
ESR	Equiva	lent Series Resistance	(G-S) Dr	ain Open,f = 1MHz		-	0.5	-	Ω
Switching	Charac	teristics							
t <sub>d(on)</sub>	1	n Delay Time				-	12	34	ns
t <sub>r</sub>	Turn-O	n Rise Time	VD	<sub>D</sub> = 75V, I <sub>D</sub> = 10A	-	-	8	26	ns
t <sub>d(off)</sub>		Turn-Off Delay Time		$V_{GS} = 10V, R_{GEN} = 4.7\Omega$ (Note 4.5)		-	15	40	ns
t <sub>f</sub>		Turn-Off Fall Time				-	3	16	ns
		do Characteristia	I						
		de Characteristic		nuard Current		-		10	A
I <sub>S</sub>		Im Continuous Drain to					-	40	A
SM		Source Diode Forward		$s = 0V, I_{SD} = 10A$		-	-	1.25	V
V <sub>SD</sub>		e Recovery Time	-	<b>0</b>	75\/	-	- 59	-	
rr		e Recovery Charge		<sub>S</sub> = 0V, I <sub>SD</sub> = 10A,V <sub>DD</sub> = /dt = 100A/μs	(Note 4)	-	124	-	ns nC
Q <sub>rr</sub>	1.000130	c. coordry onargo	- Mile		(		° <b>—</b> -т	1	



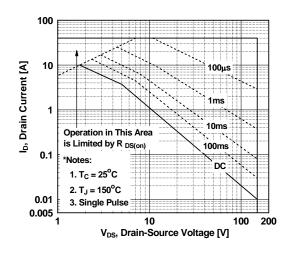




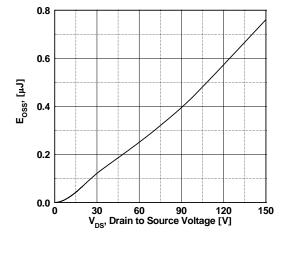
## Typical Performance Characteristics (Continued)











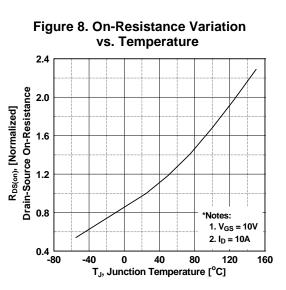
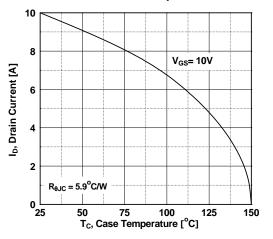
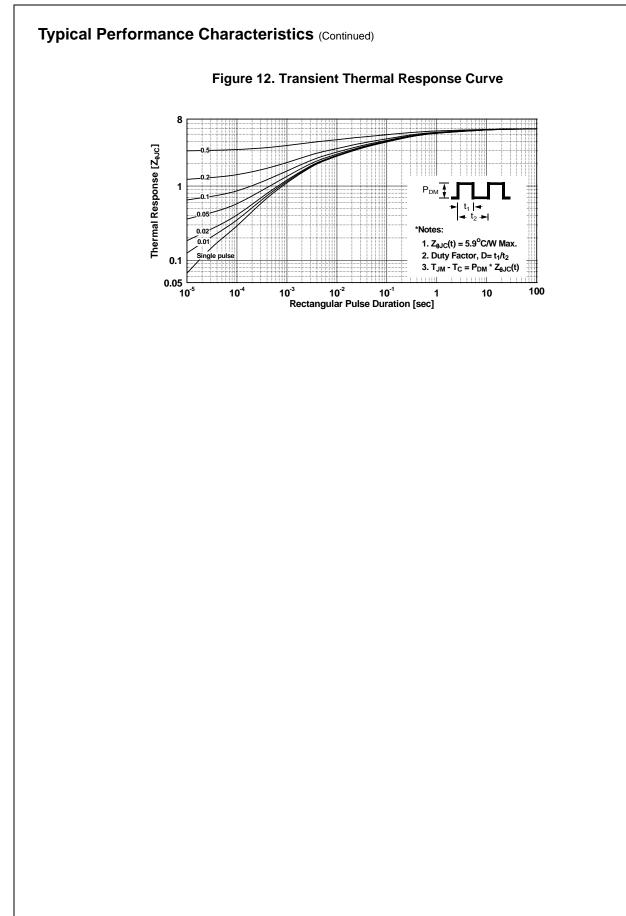
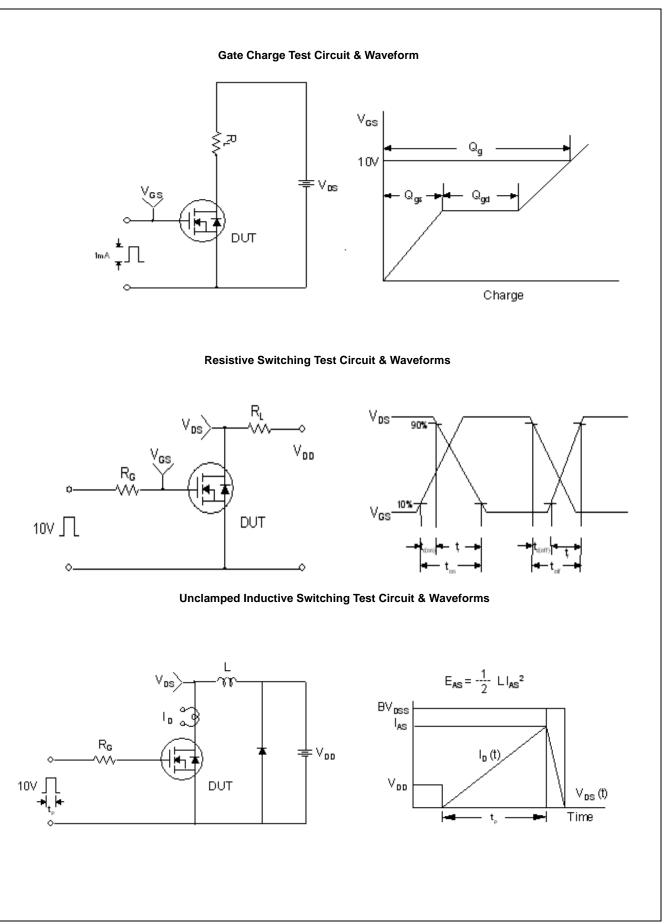


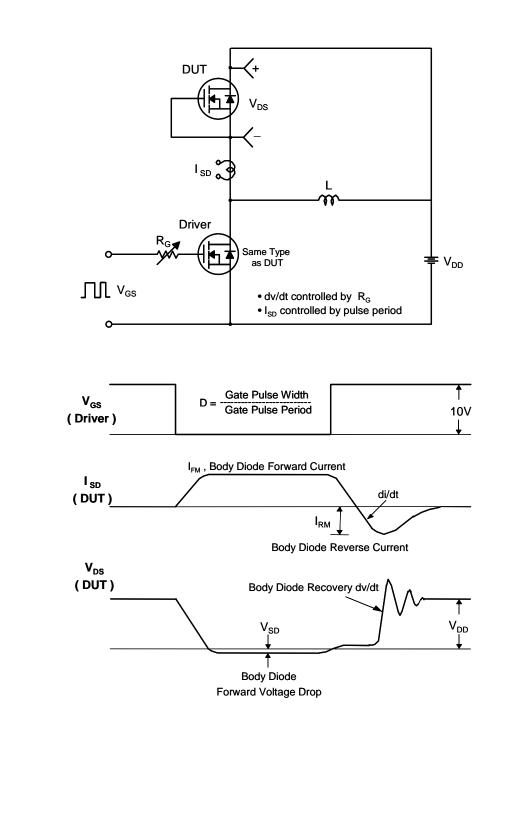
Figure 10. Maximum Drain Current vs. Case Temperature

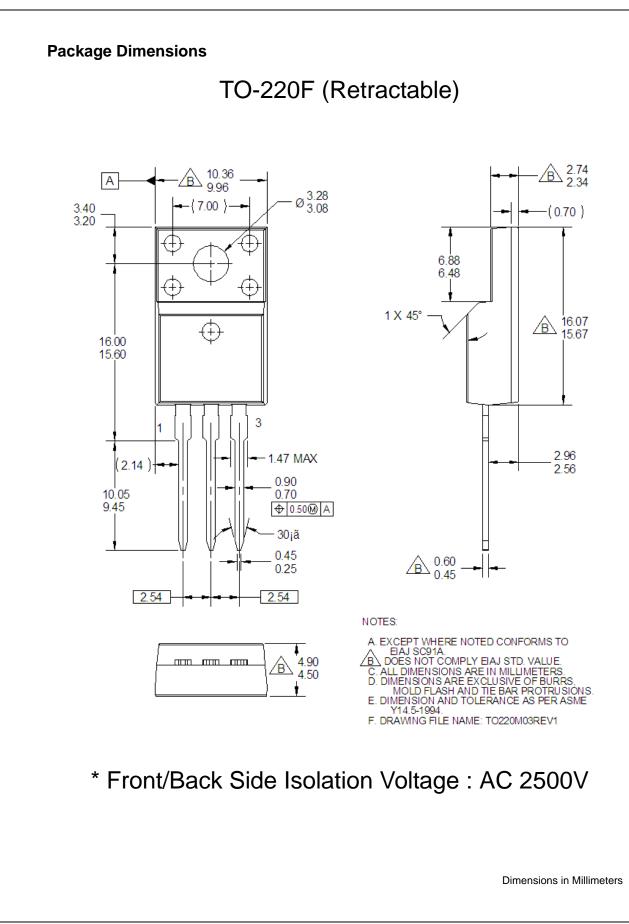


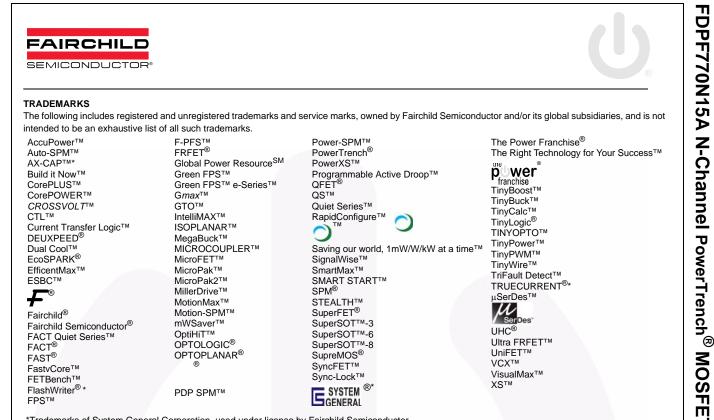




Peak Diode Recovery dv/dt Test Circuit & Waveforms







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